Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/660,721	NAGAO ET AL.	
Examiner	Art Unit	
Tuan H. Le	2622	

SEARCHED				
Class	Subclass	Date	Examiner	
348	153,159,1 43	12/13/2006	TL	
455	127.1,41	1/12/2007	TL	
340	572	1/12/2007	TL	
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INI	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor name search	12/13/2006	TL		
US-PGPUB,USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB	12/13/2006	TL		
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